Applicant(s)/Patent Under Application/Control No. Reexamination 10/712,046 KIKUCHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 EDMUND H. LEE 1732 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,468,381 10-2002 Morgan, Megan 156/244.19 Α US-В US-C US-D US-Ε US-F US-G US-Н US-US-J K US-US-L US-FOREIGN PATENT DOCUMENTS **Document Number** Date Name Country Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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